# Classification using PGMs

# 1 Setup and Notation

We are concerned with the classification task of predicting a discrete response  $Y \in \mathcal{Y}$  given a set of discrete predictors  $X = (X_1, \dots, X_p) \in \mathcal{X}^p$ . For simplicity, we will consider the case where  $\mathcal{Y} = \mathcal{X} = \{0, 1\}$ , and consider the general discrete case in the sequel. We are given n samples  $D = \{(X^{(i)}, Y^{(i)})\}_{i=1}^n$ .

The goal is to contrast generative and discriminative approaches for classification. In a generative model, we learn the joint distribution P(X,Y), and predict the response using the induced conditional distribution P(Y|X). In a discriminative model, we directly learn the conditional distribution P(Y|X).

We are interested in the case where the distribution over the predictors X could be represented using graphical models.

# 2 Generative Models

We assume that the conditional distribution of X given Y for  $Y \in \{0,1\}$  is distributed as a discrete graphical model. So, there is a separate discrete graphical model associated with  $\mathbb{P}(X|Y=0)$  and with  $\mathbb{P}(X|Y=1)$ . In the case of either graphical model, the notation and setting described below will be used.

## 2.1 Graphical model notation and assumptions.

Let  $X=(X_1,X_2,\ldots,X_p)$  denote a random vector, with each variable  $X_s$  taking values in a corresponding set  $\mathcal{X}_s$ . Say we are given an undirected graph G with vertex set  $V=\{1,\ldots,p\}$  and edge set E, so that each random variable  $X_s$  is associated with a vertex  $s\in V$ . The pairwise Markov random field associated with the graph G over the random vector X is the family of distributions of X which factorize as  $\mathbb{P}(x)\propto \exp\left\{\sum_{(s,t)\in E}\phi_{st}(x_s,x_t)\right\}$ , where for each edge  $(s,t)\in E$ ,  $\phi_{st}$  is a mapping from pairs  $(x_s,x_t)\in \mathcal{X}_s\times \mathcal{X}_t$  to the real line. For models involving discrete random variables, the pairwise assumption involves no loss of generality, since any Markov random field with higher-order interactions can be converted (by introducing additional variables) to an equivalent Markov random field with purely pairwise interactions (see Wainwright and Jordan [5] for details of this procedure).

Ising Model. In this paper, we focus on the special case of the Ising model in which  $X_s \in \{-1,1\}$  for each vertex  $s \in V$ , and  $\phi_{st}(x_s,x_t) = \theta_{st}^*x_sx_t$  for some parameter  $\theta_{st}^* \in \mathbb{R}$ , so that the distribution takes the form

$$\mathbb{P}_{\theta^*}(x) = \frac{1}{Z(\theta^*)} \exp\left\{ \sum_{(s,t)\in E} \theta_{st}^* x_s x_t \right\}. \tag{1}$$

The partition function  $Z(\theta^*)$  ensures that the distribution sums to one. As we are assuming that there are many conditional independence properties characterizing  $\mathbb{P}_{\theta^*}(x)$   $\theta^*$  can be considered to be sparse.

<sup>&</sup>lt;sup>1</sup>Note that, for  $(s,t) \notin E$ , it is convenient to define  $\phi_{st}(x_s,x_t)=0$ .

#### 2.2 Parameters and their estimation.

The graphical models associated with  $\mathbb{P}(X|Y=0)$  and with  $\mathbb{P}(X|Y=1)$  are distinct. Let  $\mathbb{P}(X|Y=0)$  and  $\mathbb{P}(X|Y=1)$  be parametrized by different parameter vectors  $\theta^{*(0)}$  and  $\theta^{*(1)}$  respectively, and let the associated graphs be  $G_0 = (V_0, E_0)$  and  $G_1 = (V_1, E_1)$ . Let  $D_i = \{(x, i) | (x, i) \in D\}$ .

#### 2.2.1 Model Estimation

Scheme 1. To estimate  $\theta^{*(0)}$  and  $\theta^{*(1)}$ , one could follow the scheme proposed by Ravikumar et. al. [4] and estimate the p parameters  $\theta_{\backslash r}^{*(i)} = \left\{ \theta_{rt}^{*(i)} | t \in V \setminus \{r\} \right\}$  associated with each vertex r by solving:

$$\hat{\theta}_{\backslash r}^{(i)} = \underset{\theta_{\backslash r}}{\arg\min} l(\theta_{\backslash r}|D_i) + \lambda_i \|\theta_{\backslash r}\|_1,$$
(2)

where  $l(\theta_{\backslash r}|D_i) = -\sum_{x \in D_i} \log \mathbb{P}_{\theta_{\backslash r}}(x_r|x_{V\backslash \{r\}})$ . Scheme 2. Suppose that  $\theta^{*(0)}$  and  $\theta^{*(1)}$  share sparsity structure. Then, one can do feature selection by solving:

$$(\hat{\theta}^{(0)}, \hat{\theta}^{(1)}) = \underset{\theta^{0}, \theta^{1}}{\arg\min} l(\theta^{1}|D_{1}) + l(\theta^{0}|D_{0}) + \lambda \sum_{j} \left\| [\theta_{j}^{1} \ \theta_{j}^{0}] \right\|_{2}. \tag{3}$$

#### Using the classifier 2.2.2

Once we have estimated the generative model parameters, we can utilize the discriminative classifier described in Equation 4, which results from the computation  $\mathbb{P}(Y=1|x) \propto \mathbb{P}(x|Y=1)\mathbb{P}(Y=1)$ .

#### 3 Discriminative Model

Consider  $\mathbb{P}(y|x)$  induced by  $(\theta^{*0}, \theta^{*1})$ , and let  $\mathbb{P}(Y=1) = q$ . Let  $E = E_0 \cup E_1$ .  $\mathbb{P}(y|x)$  is specified by

$$\mathbb{P}(Y = 1 | X = x) = \frac{\exp(\theta_0^* + \sum_{(s,t) \in E} \theta_{st}^* x_s x_t)}{1 + \exp(\theta_0^* + \sum_{(s,t) \in E} \theta_{st}^* x_s x_t)},\tag{4}$$

where  $\theta_0^* = \log(\frac{q}{Z(\theta^{*1})}) - \log(\frac{1-q}{Z(\theta^{*0})})$ , and  $\theta_{st}^* = \theta_{st}^{*1} - \theta_{st}^{*0}$ .

Given D, we could estimate this discriminative model directly, without first estimating  $\theta^{*1}$  and  $\theta^{*0}$ , by solving:

$$\hat{\theta} = \underset{\theta}{\operatorname{arg\,min}} l(\theta|D) + \lambda \sum_{j>0} |\theta_j|,\tag{5}$$

where  $l(\theta|D) = -n^{-1} \sum_{(x,y) \in D} \log \mathbb{P}_{\theta}(y|x)$ . By looking at the sparsity pattern in  $\theta^*$ , we estimate the edge-set

Note that the discriminative classifier described by Equation 4 corresponds to using the halfspace

$$f(x, \theta^{*i}) = \theta_0^{*i} + \sum_{(s,t) \in E} \theta_{st}^{*i} x_s x_t \ge 0$$
(6)

for classification.

#### Bounds on Classification Error 4

We wish to analyze the expected risk of the classifiers above as a function of n and p. In doing this, we would be following the footsteps of Ng and Jordan [2].

The hypothesis class considered while estimating  $\theta^*$  directly by solving Problem 5 is at least as large as the hypothesis class considered while estimating  $\theta^*$  by first estimating the generative model parameters. Hence, we note that as  $n \to \infty$  the expected risk of the classifier in the former case is at least as low as the estimated risk of the classifier learned by estimating  $\theta^{*1}$  and  $\theta^{*2}$  first. We now analyze the n required to learn a classifier which is almost as the classifiers mentioned for the  $n \to \infty$  case.

### 4.1 Discriminative case

### 4.1.1 Loose bounds on sample complexity

As, in the case of logistic regression, the 0/1 misclassification error  $\epsilon^m(\theta)$  is related to the logloss  $\epsilon^l(\theta)$  by  $\epsilon^l(\theta) \geq (\log 2)\epsilon^m(\theta)$ , following the analysis in [3], we note that  $n = \Omega(\log p)poly(|E|)$  suffices. <sup>2</sup>

### 4.1.2 Tighter bounds

**Theorem 1.** Suppose that  $\theta^*$  is estimated as  $\hat{\theta}$  as in Equation 5, with the exception that  $|\theta_0^*|$  is included in the regularization.

Let  $f(x, \theta^*)$  be the linear discriminant corresponding to Equation 6, and let  $sgn(f(x, \theta^*))$  be the corresponding classifier. Similarly, let  $sgn(f(x, \theta))$  be the classifier corresponding to  $\hat{\theta}$ .

Suppose that  $\theta^*$  also satisfies the conditions specified for the application of Theorem 5 of [1] in the below proof. In addition, suppose that  $Pr_x(f(x,\theta^*) \leq \mu) \leq p_2$  for  $\mu \geq k|E|\sqrt{\log p}/n$  for some constant k specified in the proof.

Then,  $Pr_y(sgn(f(x,\theta^*)) \neq sgn(f(x,\theta))) \leq p_1 + p_2$  for the failure probability  $p_1$  described in the statement of Theorem 5 in [1] <sup>4</sup>.

Proof. First, we rewrite the optimization problem so that Theorem 5 from [1] can be applied.

**Feature map.** Any data point x is mapped to z, a vector whose components are defined by:  $z_0 = 1$  and  $\{z_{ij} = x_i x_j | \forall i \neq j\}$ . The length of z is given by  $p' = \binom{p}{2} + 1 = \Theta(p^2)$ . Using this feature map, the set of points D is mapped to the set of points D'. Once this is done, all z is normalized, so that  $\forall i : |z_i| = 1/\sqrt{n}$ .

**Equivalent problem.** Next, the define parameters  $\theta'=\sqrt{n}\theta^*$ . Thus, equivalent to the model described in Equation 4, we have the model where  $\mathbb{P}(Y=i)=\sigma(i\langle\theta',z\rangle)$ , which is estimated by solving the optimization problem:

$$\hat{\theta}' = \operatorname*{arg\,min}_{\theta} l(\theta|D') + \lambda \sum_{j \ge 0} |\theta_j|,\tag{7}$$

where l() is defined as in Equation 5. Solving this optimization problem is equivalent to solving the optimization problem specified in the theorem statement.

Applying Theorem 5 from [1], using  $\lambda=k\sqrt{\frac{\log p}{n}}$  for some constant k, we then conclude that, with probability at least  $1-p_1$ :

$$\left\|\hat{\theta}' - \theta'\right\|_1 = \sqrt{n} \left\|\hat{\theta} - \theta^*\right\|_1 \le k_1 |E| \sqrt{\frac{\log p}{n}},$$

where  $k_1$  is another constant.

As  $||z||_{\infty} = 1$ , we can conclude that

$$|f(x, \theta^*) - f(x, \hat{\theta})| \le k_1 |E| \sqrt{\log p} / n.$$

Applying Claim 2, we have the result.

<sup>2</sup>It is possible that actually  $n=\Omega(|E|\log p)$  suffices when we separate the feature selection step from the final estimation step and use the VC dimension for linear classifiers: [Check]. This could improve known sample complexity for  $\ell_1$  regularized logistic regression

<sup>&</sup>lt;sup>3</sup>Note that using [1] seems to require including  $\theta_0$  in the regularization

<sup>&</sup>lt;sup>4</sup>The proof of this theorem is yet to be verified and fixed to suit our purposes.

**Remark 1.** Note that in Theorem 1, we considered an optimization problem which was slightly different from Equation 5.

To achieve misclassification rate which is at most  $p_1 + p_2$  greater than the best achievable misclassification rate, number of samples required is given by:

$$n = O(|E| \frac{\sqrt{\log p}}{\mu}).$$

Note that  $p_1$  decreases exponentially with n, so it suffices to focus on controlling  $p_2$  and  $\mu$ . In particular, if we impose conditions on  $\theta^{*i}$  such that  $\mu = \Omega(|E|)$ , we have:

$$n = O(\sqrt{\log p}).$$

### 4.2 Generative case

### 4.2.1 Loose bounds on sample complexity

Given that feature selection is done and we have an estimate  $\hat{E}$  of E, using the VC dimension of linear classifiers, we observe that  $n=O(|\hat{E}|)$  examples are sufficient to achieve a low classification error rate. Below we consider ways of characterizing the number of samples n required to get estimate  $\hat{E}\supset E$  which is not too much larger than E.

Consider Scheme 1. From [4], we know that if  $\theta^{*1}$  and  $\theta^{*2}$  satisfy certain strong conditions,  $n = O(d^3 \log p)$  is sufficient to estimate  $E_i$  accurately. Considering the fact that even  $\hat{E}_i \supset E_i$  suffices as long as it is not too much bigger than  $E_i$ , we can probably do better: that is, we should be able to use more relaxed conditions on  $\theta^{*i}$ , and we can make do with smaller n.

### 4.2.2 Tighter bounds for Scheme 1

Claim 1. Suppose that  $\theta^{*i}$  are estimated using Scheme 1. Also suppose that  $\theta^{*i}$  satisfy the conditions required by Theorem 1 in [4]. Then, with probability at least  $1-p_1$  for the failure probability  $p_1$  described in the statement of Theorem 1 in [4],

$$\left\|\theta^{*i} - \hat{\theta}^i\right\|_2 \le k_1 \sqrt{\min(p, |E_i|)} \sqrt{\frac{d\log p}{n}}$$

and

$$\left\| \theta^{*i} - \hat{\theta}^i \right\|_{\infty} \le k_2 \sqrt{\frac{d \log p}{n}},$$

for some constants  $k_1$  and  $k_2$ .

*Proof.* Considering the proof of Proposition 1 on page 17 of [4], and taking  $\lambda_n = k\sqrt{\frac{\log p}{n}}$ , we have:

$$\left\| \theta_{\backslash r}^{*i} - \hat{\theta}_{\backslash r}^{i} \right\|_{\infty} \le \left\| \theta_{\backslash r}^{*i} - \hat{\theta}_{\backslash r}^{i} \right\|_{2} \le c \sqrt{\frac{d \log p}{n}},$$

where c some constant independent of d, p, n and  $\theta_{\setminus r}$  is the vector of parameters  $\{\theta_{r,j}, \ \forall j \in V \setminus \{r\}\}$ .

From this, we already have the bound on  $\left\|\theta^{*i} - \hat{\theta}^i \right\|_{\infty}$ .

We have the bound  $\left\|\theta^{*i}-\hat{\theta}^i\right\|_2 \leq c\sqrt{p}\sqrt{\frac{d\log p}{n}}$  by applying the generalized Pythagoras theorem. We also observe from the above that  $\left\|\theta_{j,k}^{*i}-\hat{\theta}_{j,k}^i\right\|_2 \leq c\sqrt{\frac{d\log p}{n}} \forall (i,j) \in E$ . Again, applying the generalized Pythagoras theorem, we have:  $\left\|\theta^{*i}-\hat{\theta}^i\right\|_2 \leq c\sqrt{E}\sqrt{\frac{d\log p}{n}}$ . Combining these, we have the bound on  $\left\|\theta^{*i}-\hat{\theta}^i\right\|_2$ .

**Theorem 2.** Suppose that  $\theta^{*i}$  are estimated as  $\hat{\theta}^{(i)}$  using Scheme 1, and let  $f(x,\theta^*)$  be the linear discriminant corresponding to Equation 6, and let  $sgn(f(x,\theta^*))$  be the corresponding classifier. Similarly, let  $sgn(f(x,\theta))$  be the classifier corresponding to  $\hat{\theta}^{(i)}$ .

Suppose that  $\theta^{*i}$  satisfy the conditions described in Claim 1. In addition, suppose that  $Pr_x(f(x,\theta^*) \leq \mu) \leq p_2$  for  $\mu \geq k\sqrt{|E|}\sqrt{\min(p,|E|)}\sqrt{\frac{d\log p}{n}}$  for some constant k specified in the proof.

Then,  $Pr_y(sgn(f(x,\theta^*)) \neq sgn(f(x,\theta))) \leq p_1 + p_2 + p_3$  for the failure probability  $p_1$  described in the statement of Theorem 1 in [4] and  $p_3$  is specified in the proof below.

*Proof.* For some constant  $k_1$  from Claim 1, with probability at least  $1-p_1$ ,

$$\|\theta - \theta^*\|_2 \le k_1 \sqrt{\min(p, |E|)} \sqrt{\frac{d \log p}{n}}.$$

Given that this holds, as  $|x_s x_t| = 1$ ,

$$\sum_{(s,t)\in E} (\theta_{st} - \theta_{st}^*) x_s x_t \le \|\theta - \theta^*\|_2 \sqrt{|E|},$$

from applying the Holder inequality.

Hence, using Claim 3

$$\log(\frac{Z(\theta^{*0})}{Z(\hat{\theta}^{(0)})}) - \log(\frac{Z(\theta^{*1})}{Z(\hat{\theta}^{(1)})}) = O(\|\theta - \theta^*\|_2 \sqrt{|E|}).$$

$$\theta_0 - \theta_0^* = \log(\frac{q}{\hat{q}}) - \log(\frac{1-q}{1-\hat{q}}) + \log(\frac{Z(\theta^{*0})}{Z(\hat{\theta}^{(0)})}) - \log(\frac{Z(\theta^{*1})}{Z(\hat{\theta}^{(1)})}),$$

where q=Pr(Y=1) and  $\hat{q}$  is its estimate using n samples. Using Chernoff bounds, we know that  $|q-\hat{q}|=O(\frac{1}{\sqrt{n}})$  with probability at least  $1-p_3$ . So, we claim that

$$|\log(\frac{q}{\hat{q}}) - \log(\frac{1-q}{1-\hat{q}})| = O(\frac{1}{\sqrt{n}}).$$

Hence, for some constant  $k_2$ :

$$|\theta_0 - \theta_0^*| \le k_2 \sqrt{|E|} \sqrt{\min(p, |E|)} \sqrt{\frac{d \log p}{n}}$$

Applying these bounds to discriminant functions described by Equation 6, we get

$$|f(x, \theta^*) - f(x, \theta)| \le k\sqrt{|E|}\sqrt{min(p, |E|)}\sqrt{\frac{d\log p}{n}}.$$

Applying Claim 2, we have the result.

**Remark 2.** Consider Theorem 2. To achieve misclassification rate which is at most  $p_1 + p_2 + p_3$  greater than the best achievable misclassification rate, number of samples required is given by:

$$n = O(|E|\min(|E|, p)\frac{d\log p}{\mu^2}).$$

Note that  $p_1$  and  $p_3$  decrease exponentially with n, so it suffices to focus on controlling  $p_2$  and  $\mu$ . In particular, if we impose conditions on  $\theta^{*i}$  such that  $\mu = \Omega(|E|)$ , we have:

$$n = O(d \log p)$$
.

#### 4.3 Technical theorems

**Claim 2.** Suppose that a family of binary classifiers is defined by sgn(f(x)), where  $f: \mathbb{R}^p \to \mathbb{R}$  and sgn(x) is the sign function. Consider two classifiers sgn(f(x)) and sgn(g(x)).

Then, if  $Pr_x(|f(x)| < \mu) \le p_1$  and  $Pr_x(|g(x) - f(x)| \ge \mu) \le p_2$ . Then,  $Pr_x(sgn(f(x)) \ne sgn(g(x))) \le p_2$ .  $p_1 + p_2$ .

Claim 3. If 
$$|a_i - b_i| \le \epsilon$$
, then  $\log(\frac{\sum_i exp(a_i)}{\sum_i exp(b_i)}) \le O(\epsilon)$ .

*Proof.* Suppose that  $|a_i - b_i| \le \epsilon$ . Then,  $|exp(a_i) - exp(b_i)| \le exp(a_i)(1 - exp(\epsilon)) = exp(a_i)O(\epsilon)$  using the

$$\frac{\sum_{i} exp(a_{i})}{\sum_{i} exp(b_{i})} \le 1 + \left(\frac{\sum_{i} exp(a_{i}) - \sum_{i} exp(b_{i})}{\sum_{i} exp(b_{i})}\right) \le 1 + \left(\frac{\sum_{i} exp(a_{i})}{\sum_{i} exp(b_{i})}\right) O(\epsilon)$$

McLaurin series for 
$$\exp(\epsilon)$$
. 
$$\frac{\sum_{i} \exp(a_{i})}{\sum_{i} \exp(b_{i})} \leq 1 + \left(\frac{|\sum_{i} \exp(a_{i}) - \sum_{i} \exp(b_{i})|}{\sum_{i} \exp(b_{i})}\right) \leq 1 + \left(\frac{\sum_{i} \exp(a_{i})}{\sum_{i} \exp(b_{i})}\right) O(\epsilon).$$
 So, 
$$\frac{\sum_{i} \exp(a_{i})}{\sum_{i} \exp(b_{i})} \leq \frac{1}{1 - O(\epsilon)} \leq 1 + O(\epsilon).$$
 So, 
$$\log\left(\frac{\sum_{i} \exp(a_{i})}{\sum_{i} \exp(b_{i})}\right) \leq \log(1 + O(\epsilon)) \leq O(\epsilon), \text{ using the McLaurin series for } \log(1 + x).$$

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